## Notice of References Cited Application/Control No. 10/617,901 Examiner Usmaan Saeed Applicant(s)/Patent Under Reexamination DUNKLE, MARK VANDEVERT Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0105355	08-2002	Floyd et al.	324/765
	В	US-			
	С	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
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## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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